Serial No.: 09/829,505

AMENDMENTS TO THE CLAIMS

Please amend the claims as follows:

1-28. (Cancelled)

29. (Currently Amended) A semiconductor package, comprising:

a leadframe having:

a homogeneous die pad defining opposed upper and lower surfaces; and

a plurality of homogeneous bonding pads disposed at least partially about the die pad in spaced relation thereto, each of the bonding pads defining opposed upper and lower surfaces;

a die attached to the upper surface of the die pad and electrically connected to at least one of the bonding pads; and

a molding compound at least partially encapsulating the die and the leadframe such that portions of the bonding pads <u>and the die pad</u> which define the lower surfaces thereof protrude from a lower surface of the molding compound;

wherein the leadframe is subjected to a metal removal process which electrically isolates the bonding pads and the die pad from each other, and exposes the lower surface of the molding compound.

- 30. (Previously Presented) The semiconductor package of Claim 29 wherein the die is attached to the upper surface of the die pad through the use of an adhesive material.
- 31. (Previously Presented) The semiconductor package of Claim 30 wherein the adhesive material comprises an epoxy.
- 32. (Previously Presented) The semiconductor package of Claim 29 wherein the die is electrically connected to the bonding pads via bonding wires which are encapsulated by the molding compound.
- 33. (Previously Presented) The semiconductor package of Claim 29 wherein the molding compound comprises a resin.
 - 34. (Cancelled)

Serial No.: 09/829,505

35. (Previously Presented) The semiconductor package of Claim 29 wherein: the lower surface of the molding compound extends along a first plane; the lower surfaces of the bonding pads extend along a common second plane; and

the first and second planes extend in spaced, generally parallel relation to each other.

- 36. (Cancelled)
- 37. (Currently Amended) The semiconductor package of Claim 36 35 wherein the lower surface of the die pad extends along the second plane.
 - 38. (Previously Presented) The semiconductor package of Claim 29 wherein: the upper surface of the die pad is generally planar; and the upper surfaces of the bonding pads are generally planar and extend in generally co-planar relation to the upper surface of the die pad.
 - 39. (Currently Amended) A semiconductor package, comprising:
 - a leadframe having a plurality of homogeneous bonding pads defining opposed upper and lower surfaces;
 - a die electrically connected to at least one of the bonding pads; and
 - a molding compound at least partially encapsulating the die and the leadframe such that portions of the bonding pads which define the lower surfaces thereof protrude from a lower surface of the molding compound;

wherein the leadframe is subjected to a metal removal process which electrically isolates the bonding pads from each other, and exposes the lower surface of the molding compound.

- 40. (Previously Presented) The semiconductor package of Claim 39 wherein the leadframe further comprises a homogeneous die pad defining opposed upper and lower surfaces, the die being attached to the upper surface of the die pad.
- 41. (Previously Presented) The semiconductor package of Claim 40 wherein the die is attached to the upper surface of the die pad through the use of an adhesive material.
 - 42. (Previously Presented) The semiconductor package of Claim 40 wherein: the lower surface of the molding compound extends along a first plane;

Serial No.: 09/829,505

the lower surfaces of the bonding pads extend along a common second plane;

the lower surface of the die pad extends along the second plane; and the first and second planes extend in spaced, generally parallel relation to each other.

- 43. (Previously Presented) The semiconductor package of Claim 39 wherein the die is electrically connected to the bonding pads via bonding wires which are encapsulated by the molding compound.
 - 44. (Currently Amended) A semiconductor package, comprising: a leadframe having:
 - a homogeneous die pad defining opposed upper and lower surfaces; and
 - at least one homogeneous bonding pad disposed in spaced relation to the die pad and defining opposed upper and lower surfaces;
 - a die attached to the upper surface of the die pad and electrically connected to the bonding pad; and
 - a molding compound at least partially encapsulating the die and the leadframe such that a portion portions of the at least one bonding pad and the die pad which defines define the lower surface surfaces thereof protrudes protrude from a lower surface of the molding compound;

wherein the leadframe is subjected to a metal removal process which electrically isolates the at least one bonding pad and the die pad from each other, and exposes the lower surface of the molding compound.

- 45. (Previously Presented) The semiconductor package of Claim 44 wherein the die is electrically connected to the bonding pad via a bonding wire which is encapsulated by the molding compound.
 - 46. (Previously Presented) The semiconductor package of Claim 44 wherein:
 the lower surface of the molding compound extends along a first plane;
 the lower surface of the bonding pad extends along a second plane; and
 the first and second planes extend in spaced, generally parallel relation to
 each other.

Serial No.: 09/829,505

47. (Cancelled)

- 48. (Currently Amended) The semiconductor package of Claim 47 <u>46</u> wherein the lower surface of the die pad extends along the second plane.
- 49. (New) The semiconductor package of Claim 29 wherein the metal removal process is accomplished by chemically etching the leadframe.
- 50. (New) The semiconductor package of Claim 39 wherein the metal removal process is accomplished by chemically etching the leadframe.
- 51. (New) The semiconductor package of Claim 44 wherein the metal removal process is accomplished by chemically etching the leadframe.